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FDC6327C

Dual N & P-Channel 2.5V Specified PowerTrench™ MOSFET

General Description

These N & P-Channel 2.5V specified MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain low gate charge for superior switching performance.

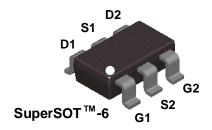
These devices have been designed to offer exceptional power dissipation in a very small footprint for applications where the bigger more expensive SO-8 and TSSOP-8 packages are impractical.

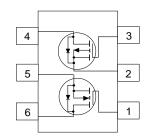
Applications

- DC/DC converter
- Load switch
- Motor driving

Features

- N-Channel 2.7A, 20V. $R_{DS(on)} = 0.08\Omega$ @ $V_{GS} = 4.5V$ $R_{DS(on)} = 0.12\Omega @ V_{GS} = 2.5V$
- P-Channel -1.6A, -20V.R $_{\rm DS(on)}$ = 0.17 Ω @ V $_{\rm GS}$ = -4.5V $R_{DS(on)} = 0.25\Omega$ @ $V_{GS} = -2.5V$
- · Fast switching speed.
- · Low gate charge.
- High performance trench technology for extremely low R_{DS(ON)}.
- SuperSOT[™]-6 package: small footprint (72% smaller than SO-8); low profile (1mm thick).





Absolute Maximum Ratings T. = 25°C unless otherwise noted

| Symbol | Parameter | | N-Channel | P-Channel | Units |
|-----------------------------------|--|-----------|------------|------------|-------|
| V _{DSS} | Drain-Source Voltage | | 20 | -20 | V |
| V _{GSS} | Gate-Source Voltage | | <u>+</u> 8 | <u>+</u> 8 | V |
| I _D | Drain Current - Continuous | (Note 1a) | 2.7 | -1.9 | Α |
| | - Pulsed | | 8 | -8 | |
| P _D | Power Dissipation | (Note 1a) | 0.0 | 96 | W |
| | | (Note 1b) | 0. | 9 | |
| | | (Note 1c) | 0. | 7 | |
| T _J , T _{stg} | Operating and Storage Junction Temperature Range | | -55 to | +150 | °C |

| Thermal Onaracteristics | | | | | |
|-------------------------|---|-----------|-----|------|--|
| $R_{\theta^{JA}}$ | Thermal Resistance, Junction-to-Ambient | (Note 1a) | 130 | °C/W | |
| $R_{\theta^{JC}}$ | Thermal Resistance, Junction-to-Case | (Note 1) | 60 | °C/W | |

Package Marking and Ordering Information

| Device Marking | Device | Reel Size | Tape Width | Quantity |
|----------------|----------|-----------|------------|----------|
| .327 | FDC6327C | 7" | 8mm | 3000 |

| Symbol | Parameter | Test Conditions | Type | Min | Тур | Max | Units |
|-----------------------------------|--|--|--------------------------------------|-------------|--|--|-------|
| Off Cha | racteristics | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ $V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$ | N-Ch P-Ch | 20 -20 | | | V |
| <u>A</u> BVnss ΔT _J | Breakdown Voltage Temperature Coefficient | $I_D = 250 \mu\text{A}$, Referenced to 25°C $I_D = -250 \mu\text{A}$, Referenced to 25°C | N-Ch P-Ch | | 12 -19 | | mV/∘C |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$ | N-Ch P-Ch | | | 1 -1 | μΑ |
| I_{GSSF} | Gate-Body Leakage, Forward | $V_{GS} = 8 \text{ V}, V_{DS} = 0 \text{ V}$ | All | | | 100 | nA |
| I _{GSSR} | Gate-Body Leakage, Reverse | $V_{GS} = -8 \text{ V}, V_{DS} = 0 \text{ V}$ | All | | | -100 | nA |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$ | N-Ch | 0.4 | 0.9 | 1.5 | V |
| | | $V_{DS} = V_{GS}, I_{D} = -250^{\circ} \mu A$ | N-Ch P-Ch | 0.4 -0.4 | 0.9 -0.9 | 1.5 -1.5 | V |
| ΔVGS(th) ΔTJ | Gate Threshold Voltage Temperature Coefficient | I_D = 250 μ A, Referenced to 25°C I_D = -250 μ A, Referenced to 25°C | N-Ch P-Ch | | -2.1 2.3 | | mV/°C |
| R _{DS(on)} | Static Drain-Source On-Resistance | $\begin{split} &V_{GS} = 4.5 \text{ V}, \ I_D = 2.7 \text{ A} \\ &V_{GS} = 4.5 \text{ V}, \ I_D = 2.7 \text{ A}, \ T_J = 125 ^{\circ}\text{C} \\ &V_{GS} = 2.5 \text{ V}, \ I_D = 2.2 \text{ A} \\ &V_{GS} = -4.5 \text{ V}, \ I_D = -1.6 \text{ A} \\ &V_{GS} = -4.5 \text{ V}, \ I_D = -1.6 \text{ A}, \ T_J = 125 ^{\circ}\text{C} \\ &V_{GS} = -2.5 \text{ V}, \ I_D = -1.3 \text{ A} \end{split}$ | N-Ch N-Ch N-Ch P-Ch P-Ch | | 0.069 0.094 0.093 0.141 0.203 0.205 | 0.08 0.13 0.12 0.17 0.27 0.25 | Ω |
| I _{D(on)} | On-State Drain Current | $V_{GS} = 2.5 \text{ V}, V_{DS} = 7.6 \text{ V}$ $V_{GS} = 4.5 \text{ V}, V_{DS} = 5 \text{ V}$ $V_{GS} = -4.5 \text{ V}, V_{DS} = -5 \text{ V}$ | N-Ch P-Ch | 8 -8 | 0.200 | 0.20 | А |
| g FS | Forward Transconductance | $V_{DS} = 5 \text{ V}, I_D = 2.7 \text{ A}$ $V_{DS} = -5 \text{ V}, I_D = -1.9 \text{ A}$ | N-Ch P-Ch | | 7.7 4.5 | | S |
| Dvnami | c Characteristics | | | | | | |
| C _{iss} | Input Capacitance | N-Channel $V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$ | N-Ch P-Ch | | 325 315 | | pF |
| C _{oss} | Output Capacitance | P-Channel | N-Ch P-Ch | | 75 65 | | pF |
| C _{rss} | Reverse Transfer Capacitance | $V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$ | N-Ch P-Ch | | 35 24 | | pF |

| Electrica | al Characteristics | (continued) | T _A = 25°C unless otherwise note | | |
|-----------|--------------------|-------------|---|------|--|
| Symbol | Parameter | Test C | Conditions | Type | |

| Symbol | Parameter | Test Conditions | Туре | Min | Тур | Max | Units | |
|---------------------|------------------------------------|---|--------------|-----|--------------|------------|-------|--|
| Switchir | Switching Characteristics (Note 2) | | | | | | | |
| $t_{\text{d(on)}}$ | Turn-On Delay Time | N-Channel $V_{DD} = 10 \text{ V}, I_D = 1 \text{ A},$ | N-Ch P-Ch | | 5 7 | 15 14 | ns | |
| t _r | Turn-On Rise Time | $V_{GS} = 4.5V$, $R_{GEN} = 6 \Omega$ | N-Ch P-Ch | | 9 14 | 18 25 | ns | |
| $t_{\text{d(off)}}$ | Turn-Off Delay Time | P-Channel $V_{DD} = -10 \text{ V}, I_D = -1 \text{ A},$ | N-Ch P-Ch | | 12 14 | 22 25 | ns | |
| t _f | Turn-Off Fall Time | V_{GS} = -4.5 V, R_{GEN} = 6 Ω | N-Ch P-Ch | | 3 3 | 9 9 | ns | |
| Q_g | Total Gate Charge | N-Channel V _{DS} = 10 V, I _D = 2.7 A, V _{GS} = 4.5V | N-Ch P-Ch | | 3.25 2.85 | 4.5 4.0 | nC | |
| Q_{gs} | Gate-Source Charge | P-Channel | N-Ch P-Ch | | 0.65 0.68 | | nC | |
| Q_{gd} | Gate-Drain Charge | $V_{DS} = -10 \text{ V}, I_{D} = -1.9 \text{ A}, V_{GS} = -4.5 \text{V}$ | N-Ch P-Ch | | 0.90 0.65 | | nC | |

Drain-Source Diode Characteristics and Maximum Ratings

| <u> </u> | Dodi do Biodo Giidi agtoriotico aria maximani ratiri | | | | |
|----------|---|------|-------|------|---|
| Is | Maximum Continuous Drain-Source Diode Forward Current | N-Ch | | 0.8 | Α |
| | | P-Ch | | -0.8 | |
| V_{SD} | Drain-Source Diode Forward $V_{GS} = 0 \text{ V}, I_S = 0.8 \text{ A}$ (Note 2) | N-Ch | 0.76 | 1.2 | V |
| | Voltage $V_{GS} = 0 \text{ V. } I_S = -0.8 \text{ A} \text{ (Note 2)}$ | P-Ch | -0.79 | -1.2 | |

Notes:

1: R_{0,JA} is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0UC} is guaranteed by design while R_{0JA} is determined by the user's board design. Both devices are assumed to be operating and sharing the dissipated heat energy equally.



a) 130 °C/W when mounted on a 0.125 in² pad of 2 oz. copper.



b) 140 °C/W when mounted on a 0.005 in² pad of 2 oz. copper.



c) 180 °C/W when mounted on a 0.0015 in² pad of 2 oz. copper.

Scale 1: 1 on letter size paper

2: Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2.0%

Typical Characteristics: N-Channel

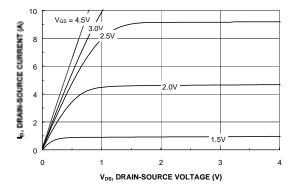


Figure 1. On-Region Characteristics.

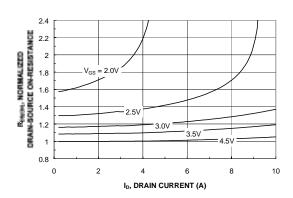


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

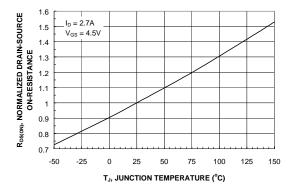


Figure 3. On-Resistance Variation with Temperature.

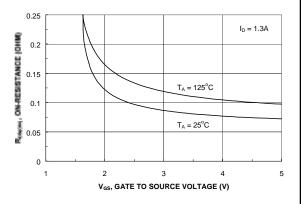


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

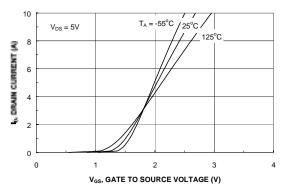


Figure 5. Transfer Characteristics.

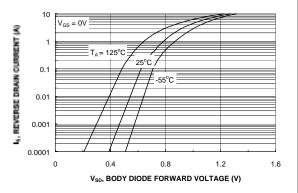
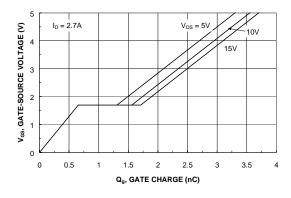


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics: N-Channel (continued)



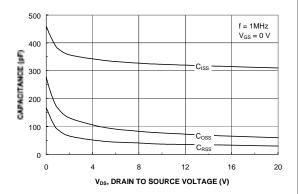
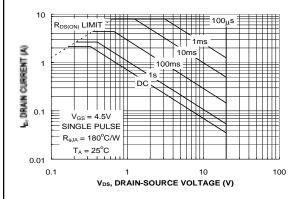


Figure 7. Gate-Charge Characteristics.

Figure 8. Capacitance Characteristics.



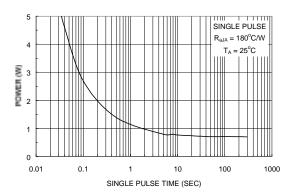
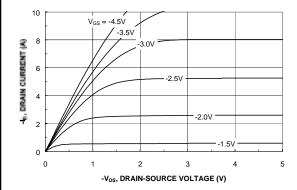


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

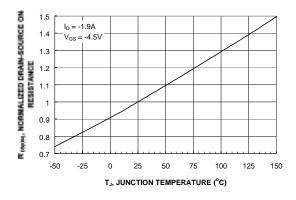
Typical Characteristics: P-Channel



2.4 2.2 V_{GS} = -2.0V 2 1.8 1.6 1.4 1.2 1 0.8 0 2 4.5V 4.5V 4.5V 4.5V 4.5V 4.5V

Figure 11. On-Region Characteristics.

Figure 12. On-Resistance Variation with Drain Current and Gate Voltage.



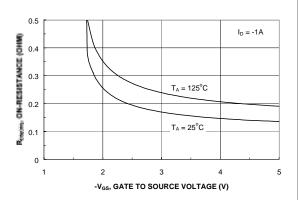
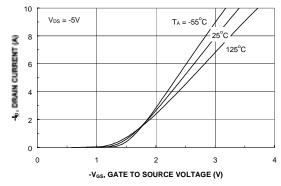


Figure 13. On-Resistance Variation with Temperature.

Figure 14. On-Resistance Variation with Gate-to-Source Voltage.



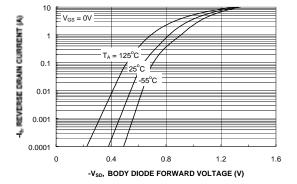
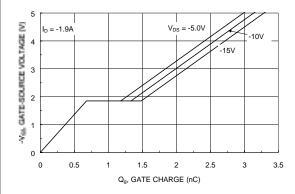


Figure 15. Transfer Characteristics.

Figure 16. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics: P-Channel (continued)



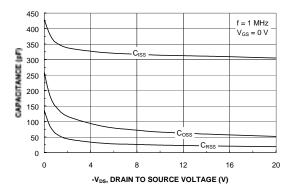
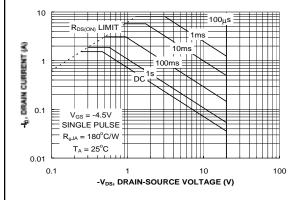


Figure 17. Gate-Charge Characteristics.

Figure 18. Capacitance Characteristics.



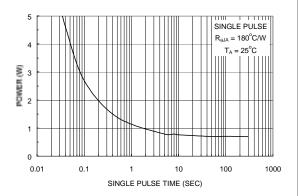


Figure 19. Maximum Safe Operating Area.

Figure 20. Single Pulse Maximum Power Dissipation.

Typical Characteristics: N & P-Channel (continued)

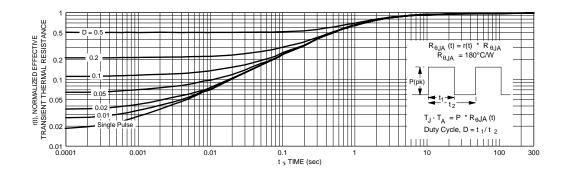


Figure 21. Transient Thermal Response Curve.

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